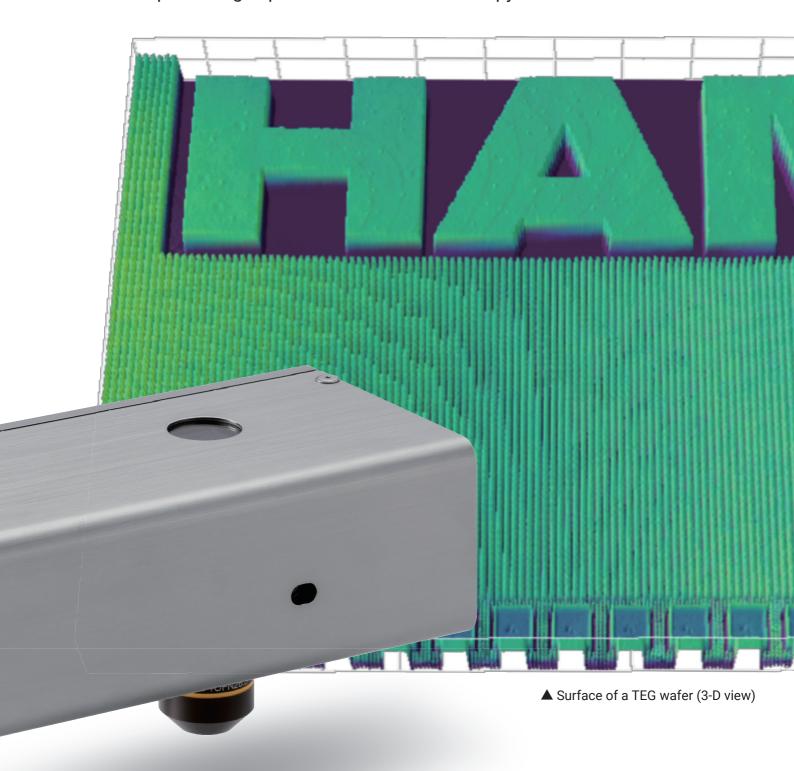


QPM optical module C16999 series

In-line compatible high-speed interference microscopy to detect surface defects



In-line compatible high-speed interference microscopy to detect surface defects

This is an optical module for building interference microscope, "QPM (Quantitative Phase Microscopy)" which provides nano-scale vertical resolution.

Our proprietary technology enables a compact and lightweight module that is capable of high-speed and real-time measurement.

Incorporated into 3D metrology system, it enables in-line application that leads to cost reduction.

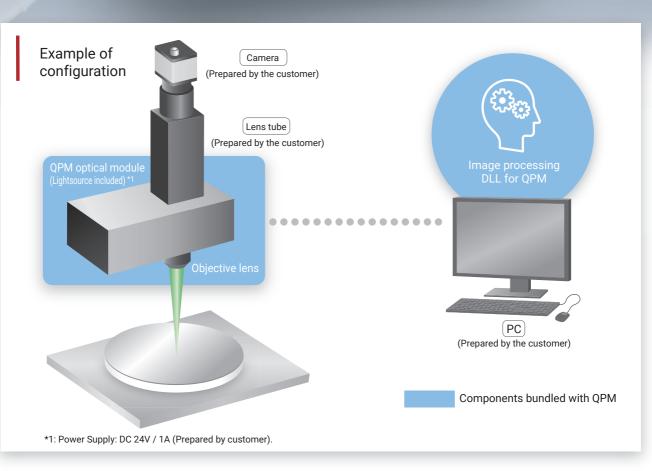
Features

- · Compact and lightweight
- Compatible with in-line configuration (for embedded applications)
- · High-speed and real-time measurement
- · Reduced total cost

Applications

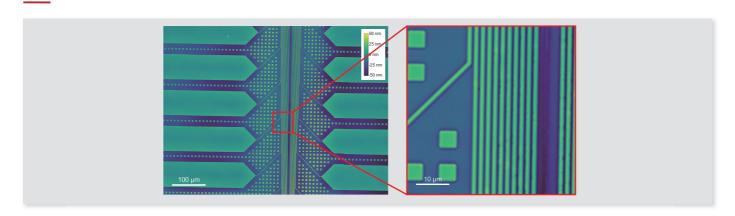
- Defect inspection on semiconductor surface
- Microparticle inspection





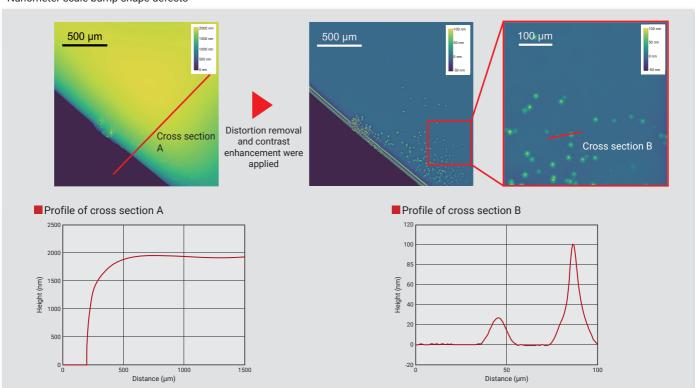
QPM image examples

Suface of a TEG wafer



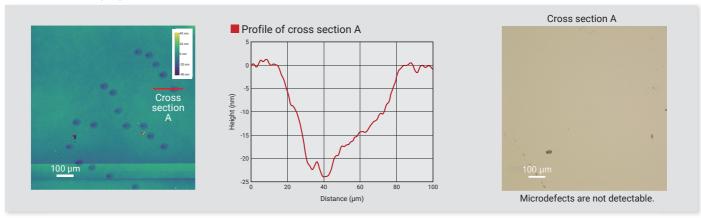
Surface of a semiconductor wafer (around the edge)

·Nanometer scale bump-shape defects



Surface of a compound semiconductor wafer

•20 nm to 30 nm depth pit defects



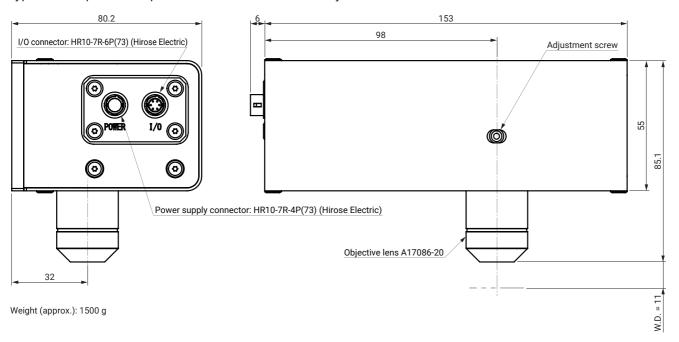
Specifications

Parameters	High magnification model			Low magnification model			Ultra-low magnification model	l Unit
	C16999-10			C16999-20			C16999-30	
Objective lens (sold separately)	A17086-10	A17086-20	A17086-30	A17086-40	A17086-50	A17086-60	A17086-70	-
Lens magnifications	×20	×10	×5	×10	×5	×2	×1.25	_
Vertical resolution *1	0.5 or less							nm
Horizontal resolution	0.72	1.1	2.2	1.1	2.2	4.1	8.1	μm
Field of view	0.707 × 0.517	1.41 × 1.04	2.83 × 2.07	1.41 × 1.04	2.83 × 2.07	7.07 × 5.17	11.3 × 8.28	mm
QPM image acquisition rate *2	25							fps
Z measurement range	±1.3	±3	±12	±3	±12	±12	±15	μm
W.D.	3.1	11	20	11	20	6.2	5	mm

^{*1:} Reproducibility of the optical path length measured for the level difference on a height-standard test chart.

Dimensions (unit: mm)

Typical example: QPM optical modules C16999-10 + Objective lens A17086-20



• Information described in this material current as of August 2024. Specifications are subject to change without notice.

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^{*2:} When shooting at a camera frame rate of 200 fps.

^{*} The specifications are the optical performance when using each objective lens combined by our recommended camera and our recommended lens tube.